COMPARISON OF THE VALENCE BAND OF THE Mn/GeTe, Mn/GeMnTe AND Mn/GeEuTe LAYERS

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Resonant photoemission spectroscopy (RPES) belongs to experimental techniques developed thanks to access to sources of synchrotron radiation. Wide, continuous spectrum of SR enables studying photoemission for photon energies close to a particular intra-system transition. RPES is particularly useful for studying contribution of partly filled shells (d or f) of transition metals or rare earth elements to the electronic structure of a system. This technique is based on the Fano effect in which rare earth (RE) 4f and transition metal (TM) 3d electrons are locally and selectively excited when the photon energy is tuned to the RE $4d \rightarrow 4f$ and TM $3p \rightarrow 3d$ transition. The photoemission intensity in the resonance region is described by the Fano line shape [1], which consists of a resonance maximum and an antiresonance minimum. Comparison of the spectra measured for these two photon energies allows determination of *f*- and *d*-related emission.

The comparison of the experimental results, which have been received in the photoemission study of electronic structure of GeTe doped with Mn and/or Eu, is presented in this work. The IV-VI crystals are known to form solid solutions not only with magnetic ions with uncompletely filled 3d shell (*e.g.* Mn, Fe), but also with the elements with uncompletely filled 4f shell (*e.g.* Eu, Gd) [2]. Eu-doped IV-VI crystals can be effectively applied for the construction of mid-infrared tunable detectors and lasers. In Eu-doped IV-VI crystals, Eu ions interact ferromagnetically via the RKKY mechanism. The substitutional europium ions occur as Eu²⁺, however, sometimes Eu³⁺ can also be detected, especially at disordered surfaces. Presence of Eu³⁺ related spectra features indicates a deviation from stechiometry.

 $Ge_{1-x}Mn_xTe$ becomes ferromagnetic with a relatively high Curie temperature - 140 K. T_C of $Ge_{1-x}Mn_xTe$ depends strongly on Mn concentration [3]. However the introduction of Eu ions to the system leads to a similar Curie temperature but for markedly lower Mn contents [4]. Therefore, the properties of $Ge_{1-x}Mn_xTe$ and related systems attract considerable interest, due to possible applications of IV-VI-based systems for fabrication of spintronic devices.

However, Ge_{1-x}Mn_xTe and related solid solutions can obtained as policrystalline bulk sample or be monocristalline epilayers. Monocrystalline samples of $Ge_{1-x-v}Mn_xEu_vTe$ are not available yet. In order to carry out a thorough, comparative study of all these systems, a set of GeTe, Ge_{0.9}Mn_{0.1}Te and Ge_{0.98}Eu_{0.02}Te layers was prepared. The samples were grown on BaF₂ (111) substrates by an MBE method with the use of effusion cells as GeTe, Eu, Te₂ and Mn sources. The substrate temperature was 400-450°C. The content of Mn in Ge0.9Mn0.1Te and Eu in Ge0.98Eu0.02Te were checked by energy dispersive X-ray fluorescence analysis. After first photoemission studies of GeTe, $Ge_{0.9}Mn_{0.1}Te$, Ge_{0.98}Eu_{0.02}Te, Mn atoms were introduced into the surface layer of the samples by Mn deposition at room temperature and annealing the sample in ultra high vacuum. In particular, the $Ge_{1-x-v}Mn_xEu_vTe$ surface alloy were prepared by this method. Then, the valence bands of the surface alloys were investigated by means of RPES.

The photoemission measurements were performed at the FLIPPER II beamline (E1) in HASYLAB (Germany). The spectra of GeTe, Ge_{0.9}Mn_{0.1}Te, Ge_{0.98}Eu_{0.02}Te were measured for the photon energy range of 130 - 160 eV (corresponding to Eu $4d \rightarrow 4f$ resonance for both Eu²⁺ and Eu³⁺) and 30-60 eV (Mn $3p\rightarrow 3d$).

Fig. 1 shows a typical set of energy distribution curves taken at photon energies 50 eV near to the Mn 3p-3d resonance for clean GeTe, $Ge_{0.9}Mn_{0.1}Te$ and $Ge_{1-x}Eu_xTe$ samples, after deposition of manganese and after annealing. In the case of the $Ge_{0.98}Eu_{0.02}Te$ the peak located around 2.0 eV below the Fermi level in the clean sample can be associated with the Eu^{2+} 4*f* final state multiplet contribution to the emission from the valence band. The Mn 3*d* states contribution occurred in the upper part of the valence band, with a maximum at the binding energy of about 4.6 eV. Its shape corresponded to that expected for Mn²⁺ ions surrounded by six Te ions in the octahedral coordination. Deposition of Mn and annealing the system led to an increase of Mn 3*d* feature intensity without any change in its shape. This proved



Figure 1. The valence band spectra of GeTe, $Ge_{0.9}Mn_{0.1}Te$ and $Ge_{0.98}Eu_{0.02}Te$ measured for clean samples, after deposition of manganese and after annealing, for photon energies 50 eV.

that diffusing Mn ions occupied the same sites in the lattice as those introduced during the layer growth. Increase of Mn contents in the subsurface layer correlates with increase of the sample magnetization. Its relation with magnetic properties of the system is discussed.

For $Ge_{1-x-y}Mn_xEu_yTe$, the valence band density of states distribution was determined for the first time, to our knowledge. The Mn 3*d* contribution to the electronic structure of the system was revealed and changes in the Eu-related feature corelated with presence of Mn ions were analyzed.

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